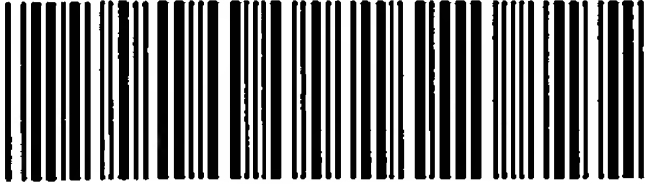


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/627,437	DEANE, PETER	
	Examiner	Art Unit	
	Sung H. Pak	2874	

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385	49,88,89, 91-94	3/5/2005	SP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search: USPAT; USPGPUB; EPO; JPO; DERWENT; IBM see text search notes	3/5/2005	SP